

Application/Control No.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0161141	08-2004	Dewaele, Piet	382/132
	В	US-			
	O	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	ט	Verbeek et al. "On the Location Error of Curved Edges in Low-Pass Filtered 2-D and 3-D Images." IEEE Transactions on Pattern Analysis and Machine Intelligence, vol.16, No.7, July 1994, pp.726-733.				
	٧	Maintz et al. "Evaluation of Ridge Seeking Operators for Multimodality Medical Image Matching." IEEE Transactions on Pattern Analysis and Machine Intelligence, vol.18, no.4, April 1996, pp.353-365.				
	w	Bouma, Henri. "Edge Location and Curvature." Poster given at a BME research meeting, May 14, 2003, at the Technische Universiteit, Einhoven				
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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